Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/750,025	LIN, JYH CHAIN		
Examiner	Art Unit		
Wilson Lee	2821		

SEARCHED						
Class	Subclass	Date Examin				
315	291 .	3/25/2005 WL				
	224					
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	307					
	105					
	172					
315	176	↓	V			
250	205	3/25/2005	WL			

INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)								
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